

# AUIRFZ44N

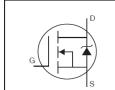
HEXFET<sup>®</sup> Power MOSFET

### Features

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

# Description

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V <sub>DSS</sub>	55V 17.5mΩ		
R <sub>DS(on)</sub> max.	17.5mΩ		
I <sub>D</sub>	49A		



G	G D	
Gate	Drain	Source

Base part number	Backago Typo	Standard Pack Orderable Part Nu		Orderable Bart Number
Dase part number	Package Type	Form	Quantity	Olderable Fait Nulliber
AUIRFZ44N	TO-220	Tube	50	AUIRFZ44N

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	49		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	35	A	
I <sub>DM</sub>	Pulsed Drain Current ①	160		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	94	W	
	Linear Derating Factor	0.63	W/°C	
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 6	150		
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy Tested Value (5)	530	— mJ	
I <sub>AR</sub>	Avalanche Current ①	25	A	
E <sub>AR</sub>	Repetitive Avalanche Energy ①	9.4	mJ	
dv/dt	Peak Diode Recovery dv/dt3	5.0	V/ns	
TJ	Operating Junction and	-55 to + 175		
T <sub>STG</sub>	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)		

#### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case		1.5	
$R_{ ext{ heta}CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{ heta JA}$	Junction-to-Ambient		62	

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\*Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.058		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			17.5	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 25A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
gfs	Forward Trans conductance	19			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 25A ④
1	Drain-to-Source Leakage Current			25		V <sub>DS</sub> =55 V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>				250		V <sub>DS</sub> =44V,V <sub>GS</sub> = 0V,T <sub>J</sub> =150°C
1	Gate-to-Source Forward Leakage			100	<b>n</b> A	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Q <sub>g</sub>	Total Gate Charge			63		I <sub>D</sub> = 25A
$Q_{gs}$	Gate-to-Source Charge			14	nC	$V_{DS} = 44V$
Q <sub>gd</sub>	Gate-to-Drain Charge			23		$V_{GS}$ = 10V , See Fig. 6 and 13
t <sub>d(on)</sub>	Turn-On Delay Time		12			V <sub>DD</sub> = 28V
t <sub>r</sub>	Rise Time		60		ns	I <sub>D</sub> = 25A
t <sub>d(off)</sub>	Turn-Off Delay Time		44		115	R <sub>G</sub> = 12Ω
t <sub>f</sub>	Fall Time		45			V <sub>GS</sub> = 10V, See Fig. 10 ④
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
C <sub>iss</sub>	Input Capacitance		1470			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		360		pF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		88			<i>f</i> = 1.0MHz, See Fig. 5
E <sub>As</sub>	Single pulse Avalanche Energy		<b>530</b> ⑤	1506	mJ	I <sub>AS</sub> = 25A, L = 0.47mH
<b>Diode Chara</b>	acteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current					MOSFET symbol
I <sub>S</sub>	(Body Diode)			49	^	showing the
Is I <sub>SM</sub>	(Body Diode) Pulsed Source Current (Body Diode) ①			49 160	A	
	Pulsed Source Current				A	showing the integral reverse
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①		  63	160	A V	showing the integral reverse p-n junction diode.
I <sub>SM</sub> V <sub>SD</sub>	Pulsed Source Current (Body Diode) ① Diode Forward Voltage		  63 170	160 1.3	A V	showing the integral reverse p-n junction diode. $T_J = 25^{\circ}C, I_S = 25A, V_{GS} = 0V$ ④

#### Notes:

- 0 Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting  $T_J = 25^{\circ}C$ , L = 0.48mH,  $R_G = 25\Omega$ ,  $I_{AS} = 25A$  (See fig. 12)
- $(3) \quad I_{SD} \leq 25A, \, di/dt \leq \, 230A/\mu s, \, V_{DD} \leq \, V_{(BR)DSS}, \, T_J \leq 175^\circ C$
- ④ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- © This is a typical value at device destruction and represents operation outside rated limits.
- $\ensuremath{\textcircled{}^{\circ}}$  This is a calculated value limited to  $T_J$  = 175°C .



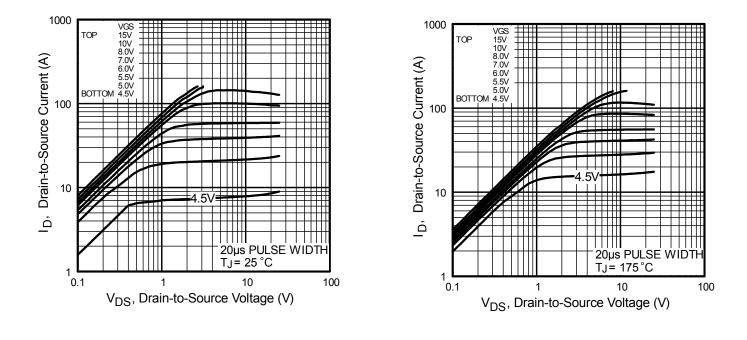


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

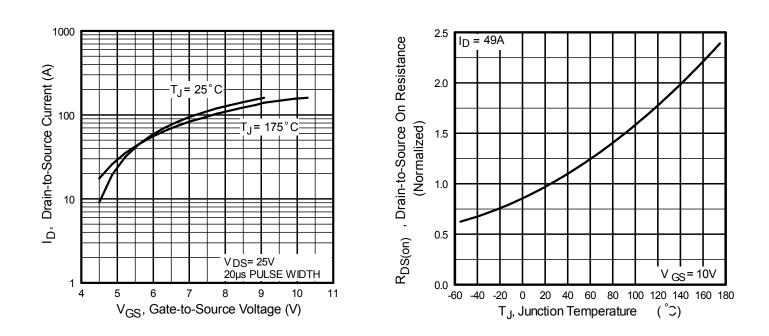


Fig. 3 Typical Transfer Characteristics

Fig. 4 Normalized On-Resistance Vs. Temperature



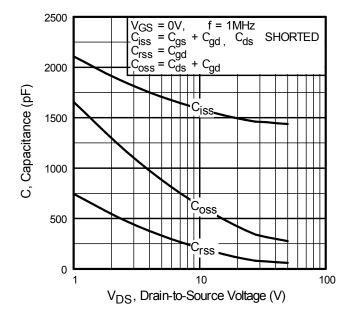
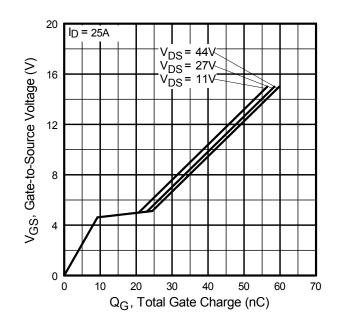
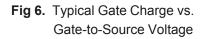
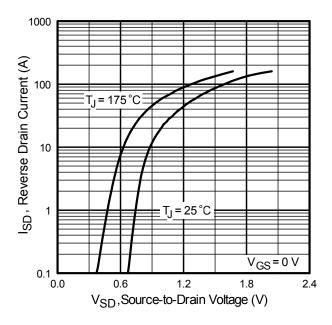


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage









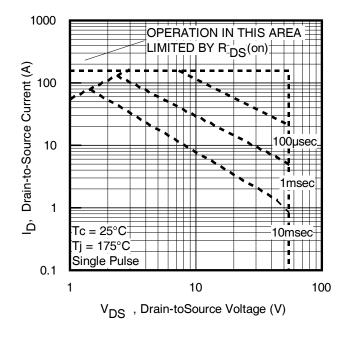


Fig 8. Maximum Safe Operating Area

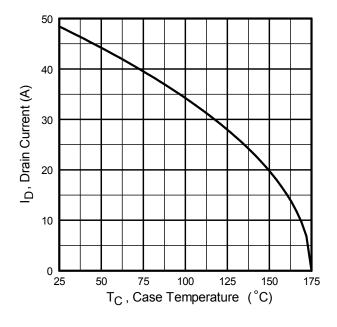


Fig 9. Maximum Drain Current vs. Case Temperature

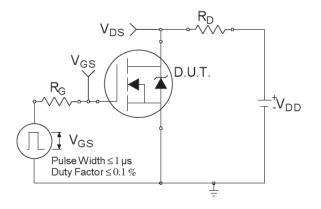


Fig 10a. Switching Time Test Circuit

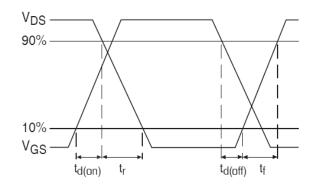


Fig 10b. Switching Time Waveforms

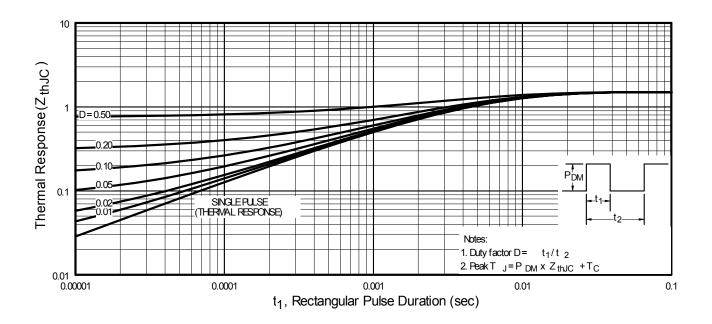


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

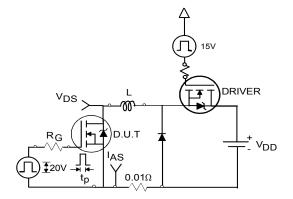
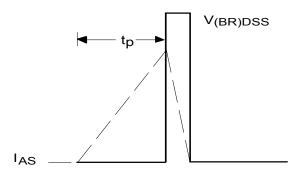


Fig 12a. Unclamped Inductive Test Circuit



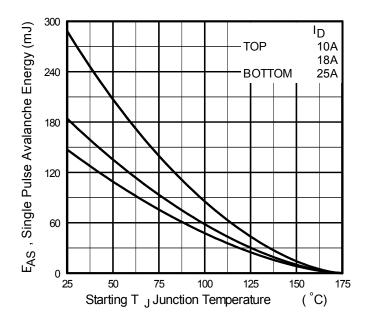


Fig 12c. Maximum Avalanche Energy vs. Drain Current

Fig 12b. Unclamped Inductive Waveforms

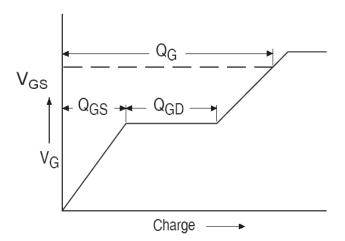


Fig 13a. Gate Charge Waveform

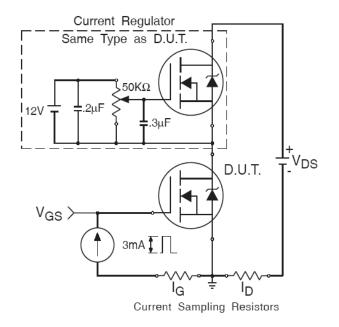
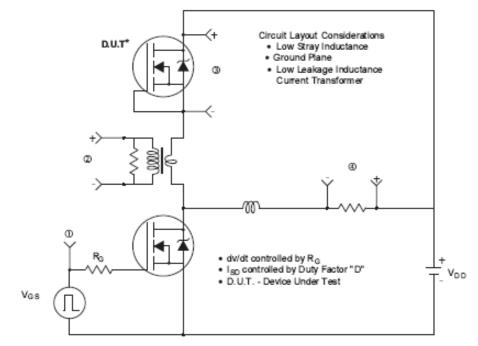


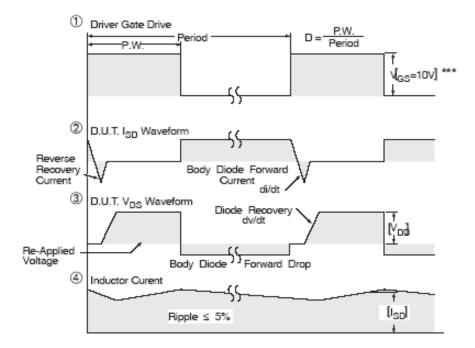
Fig 13b. Gate Charge Test Circuit





# Peak Diode Recovery dv/dt Test Circuit

\* Reverse Polarity of D.U.T for P-Channel

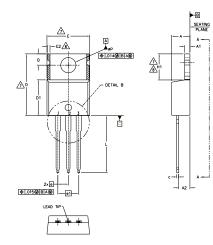


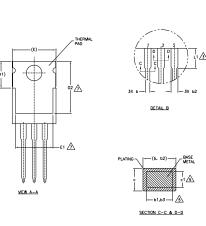
\*\*\* V<sub>GS</sub> = 5.0V for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



# TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





- NOTES:
- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- 2.-
- 3 -
- DIMENSIONING AND TOLERAINCING AS PER ASME 114.5 MF 1934. DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS] LEAD DIMENSION AND FINISH UNCONTROLLED IN L1. DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- <u>/5.-</u> DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- 6.-CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 7. – 8.-
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- UTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9.-

	DIMENSIONS				
SYMBOL	MILLIMETERS		INC		
	MIN.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	1.14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
е	2.54	BSC BSC	.100	BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øР	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

#### LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE

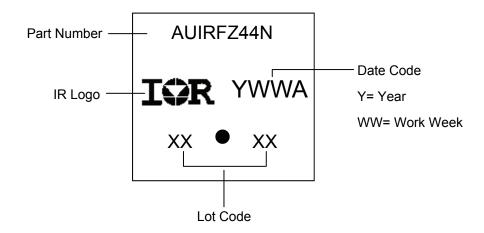
IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

#### **TO-220AB Part Marking Information**



TO-220AB package is not recommended for Surface Mount Application.



# **Qualification Information**

		Automotive (per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Se	nsitivity Level	3L-TO-220AB	N/A		
	Machine Model	Class M3 (+/- 400V) <sup>†</sup>			
		AEC-Q101-002			
ESD	Human Dady Madal	Class H1C (+/- 1250V) <sup>†</sup>			
ESD	Human Body Model	AEC-Q101-001			
	Charged Device Medal	Class C5 (+/- 1250V) <sup>†</sup>			
	Charged Device Model	AEC-Q101-005			
RoHS Compliant			Yes		

† Highest passing voltage.

### **Revision History**

Date	Comments			
9/25/2017	<ul> <li>Updated datasheet with corporate template.</li> <li>Corrected typo error on package outline and part marking on page 8.</li> </ul>			

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